TOSHIBA Field Effect Transistor Silicon N-Channel MOS Type (U-MOS V-H)

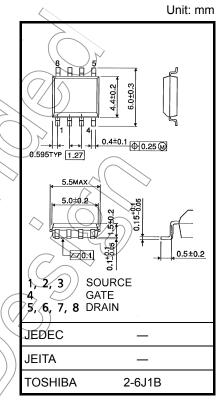
ТРС8037-Н

High-Efficiency DC-DC Converter Applications Notebook PC Applications Portable Equipment Applications

- Small footprint due to a small and thin package
- High-speed switching
- Small gate charge: QSW = 5.0 nC (typ.)
- Low drain-source ON-resistance: R_{DS} (ON) = 7.6 m Ω (typ.)
- High forward transfer admittance: $|Y_{fs}| = 36 \text{ S} (typ.)$
- Low leakage current: $I_{DSS} = 10 \ \mu A \ (max) \ (V_{DS} = 30 \ V)$
- Enhancement mode: $V_{th} = 1.5$ to 2.5 V ($V_{DS} = 10$ V, $I_D = 1$ mÅ)

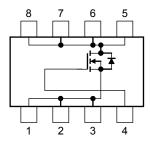
Absolute Maximum Ratings (Ta = 25°C)

			(\bigcirc)	*
Characteristic		Symbol	Rating	⊖ Unit
Drain-source voltage		V _{DSS}	30	V
Drain-gate voltage ($R_{GS} = 20 \text{ k}\Omega$)		V _{DGR (}	30	V
Gate-source voltage		V _{GSS}	<u>+</u> 20	< <v td="" y<=""></v>
Drain current	DC (Note 1)	ID	12	A
	Pulsed (Note 1)	LDR	48	
Drain power dissipation $(t = 10 s)$			1.9	w
	(Note 2a)		//	
Drain power dissipation (t = 10 s) (Note 2b)		Po	1.0	Ŵ
Single-pulse avalanch	ne energy (Note 3)	EAS	94	mJ
Avalanche current		IAR	12	A
Repetitive avalarche energy		EAR	0.18	mJ
Channel temperature		(^{Ti} ch	150	°C
Storage temperature range		Tstg	-55 to 150	°C



Weight: 0.085 g (typ.)

Circuit Configuration



Note: For Notes 1 to 4, refer to the next page.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

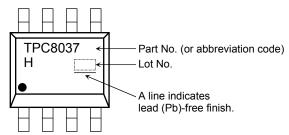
This transistor is an electrostatic-sensitive device. Handle with care.

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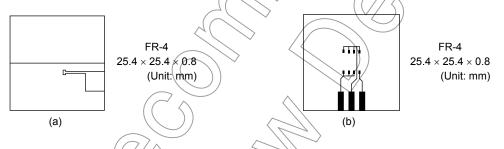
Thermal Characteristics

Characteristic	Symbol	Max	Unit	
Thermal resistance, channel to ambient (t = 10 s) (Note 2a)	R _{th (ch-a)}	65.8	°C/W	
Thermal resistance, channel to ambient (t = 10 s) (Note 2b)	R _{th (ch-a)}	125	°C/W	

Marking (Note 5)

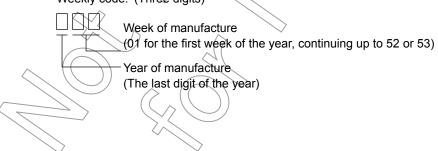


- Note 1: Ensure that the channel temperature does not exceed 150°C.
- Note 2: (a) Device mounted on a glass-epoxy board (a)



(b) Device mounted on a glass-epoxy board (b)

- Note 3: $V_{DD} = 24 \text{ V}, \text{ T}_{ch} = 25^{\circ} \text{ C}$ (initial), $L = 500 \text{ }\mu\text{H}, \text{ R}_{G} = 25 \Omega, \text{ I}_{AR} = 12 \text{ A}$
- Note 4: Repetitive rating: pulse width limited by maximum channel temperature
- Note 5: on lower left of the marking indicates Pin 1.
 - * Weekly code: (Three digits)



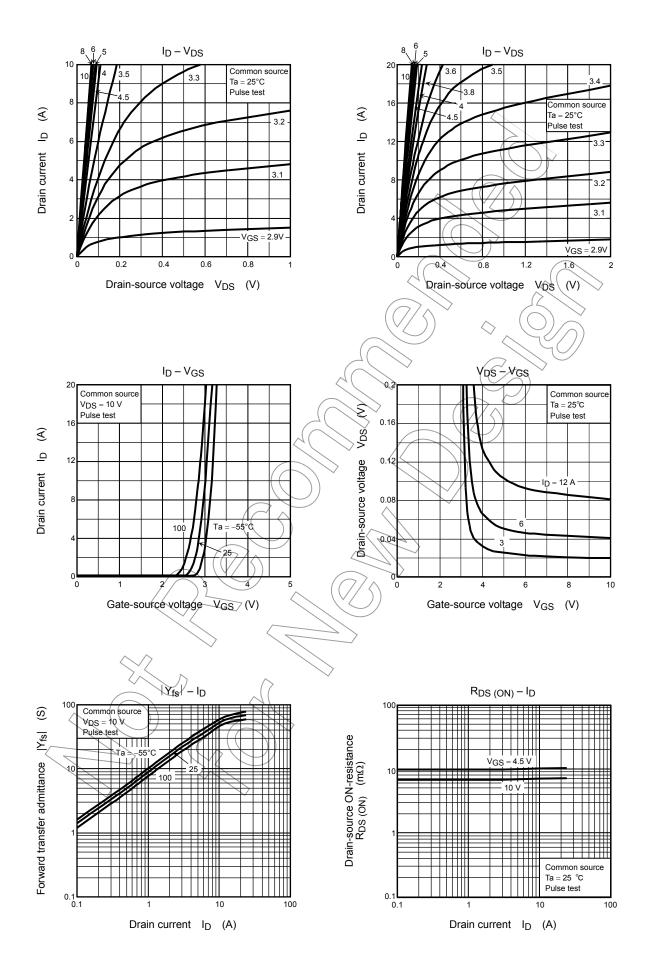
Electrical Characteristics (Ta = 25°C)

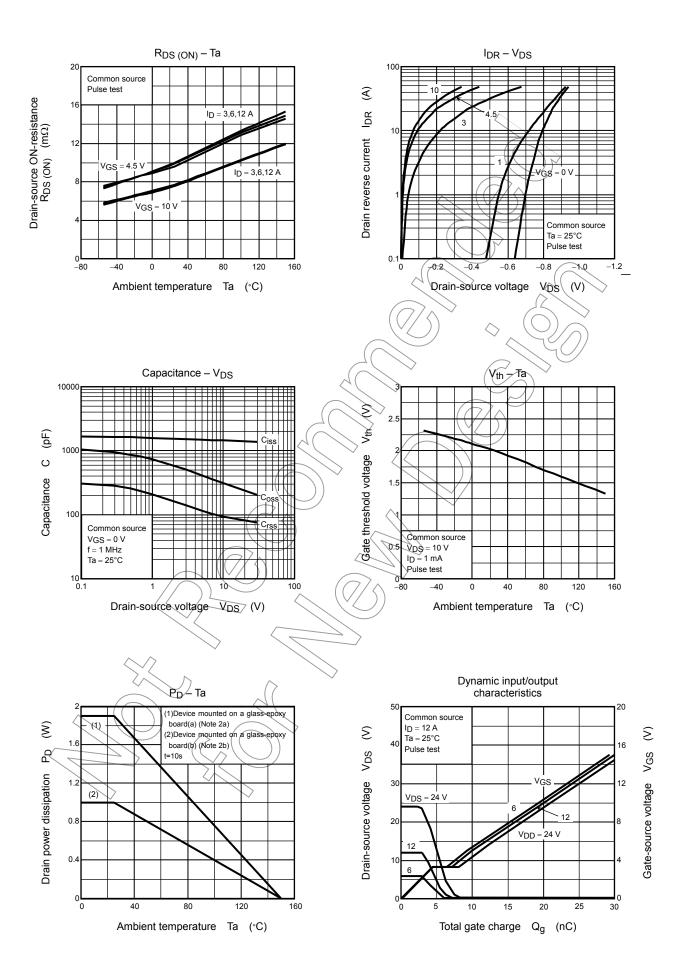
Ch	aracteristic	Symbol	Test Condition	Min	Тур.	Max	Unit	
Gate leakage cur	rent	I _{GSS}	$V_{GS}=\pm 20~V,~V_{DS}=0~V$	_	—	±100	nA	
Drain cutoff curre	ent	I _{DSS}	$V_{DS} = 30 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$			10	μA	
Drain-source breakdown voltage		V (BR) DSS	$I_D = 10 \text{ mA}, V_{GS} = 0 \text{ V}$	30	—	_	V	
		V (BR) DSX	$_{\rm D}$ = 10 mA, V _{GS} = -20 V 15			_	v	
Gate threshold vo	oltage	V _{th}	$V_{DS} = 10 \text{ V}, \text{ I}_{D} = 1 \text{ mA}$	1.5		2.5	V	
Drain-source ON-resistance		R _{DS (ON)}	$V_{GS} = 4.5 \text{ V}, \text{ I}_{D} = 6 \text{ A}$	2	9.9	13.9	mΩ	
			$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 6 \text{ A}$	\mathcal{A}	7.6	11.4		
Forward transfer	admittance	Y _{fs}	$V_{DS} = 10 \text{ V}, \text{ I}_{D} = 6 \text{ A}$	18	36	_	S	
Input capacitance		C _{iss}			1433	2150		
Reverse transfer capacitance		C _{rss}	$V_{DS} = 10 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	_	83	125	pF	
Output capacitance		C _{oss}			< 303	\searrow		
Gate resistance		Rg	$V_{DS} = 10 \text{ V}, V_{GS} = 0 \text{ V}, f = 5 \text{ MHz}$	-6	1.0	> 1.5	Ω	
Switching time	Rise time	tr	$10\sqrt{10}$ $I_D = 6 A$	K	3) _	20	
	Turn-on time	t _{on}	$V_{GS} \xrightarrow{10} V \xrightarrow{10} V_{OUT}$		10	_		
	Fall time	t _f			3.9	_	– ns	
	Turn-off time	toff	Duty \leq 1%, t _w = 10 µs	_	23	_		
Total gate charge (gate-source plus gate-drain)		Qg	$V_{DD} \approx 24 \text{ V}, \text{ V}_{GS} = 10 \text{ V}, \text{ I}_{D} = 12 \text{ A}$		21	_		
			$V_{DD} \approx 24 \text{ V}, \text{ V}_{GS} = 5 \text{ V}, \text{ I}_{D} \neq 12 \text{ A}$		11	_		
Gate-source char	rge 1	Qĝs1			4.4	_	nC	
Gate-drain ("Miller") charge		Qgđ	$V_{DD} \approx 24 V, V_{GS} = 10 V, I_D = 12 A$		3.7	_		
Gate switch charge		Qsw		_	5.0	_		

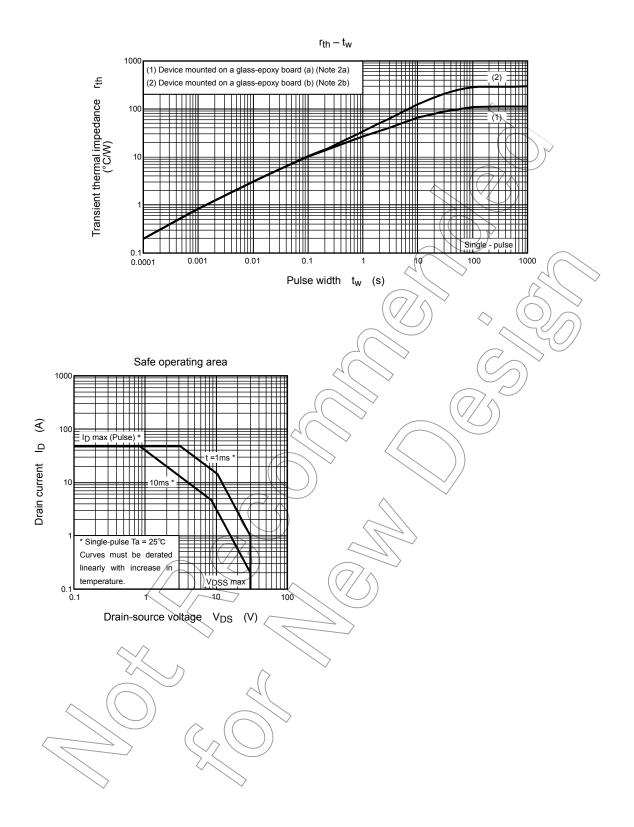
Source-Drain Ratings and Characteristics (Ta $= 25^{\circ}$ C)

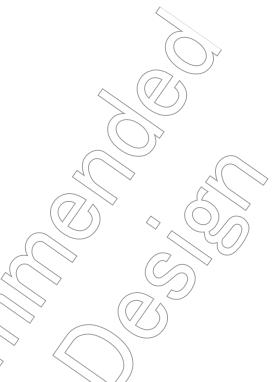
Characteristic	Symbol	Min	Тур.	Max	Unit	
Drain reverse current Pulse (Note 1)	IDRP	—	_	_	48	А
Forward voltage (diode)	V_{DSF} $I_{\text{DR}} = 12$	2 A, V _{GS} = 0 V	_	_	-1.2	V

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